

QUERY CONTROL FORM		RTIS USE ONLY	
Application No. 09/960,383	Prepared by BSH	Tracking Number 05981863	
Examiner-GAU mercader-3737	Date 08/05/04	Week Date 07-19-2004	
No. of queries 1		IFW-RU8	

JACKET

a. Serial No.	f. Foreign Priority	k. Print Claim(s)	p. PTO-1449
b. Applicant(s)	g. Disclaimer	l. Print Fig.	q. PTOL-85b
c. Continuing Data	h. Microfiche Appendix	m. Searched Column	r. Abstract
d. PCT	i. Title	n. PTO-270/328	s. Sheets/Figs
e. Domestic Priority	j. Claims Allowed	o. PTO-892	t. Other

SPECIFICATION

- a. Page Missing
- b. Text Continuity
- c. Holes through Data
- d. Other Missing Text
- e. Illegible Text
- f. Duplicate Text
- g. Brief Description
- h. Sequence Listing
- i. Appendix
- j. Amendments
- k. Other

CLAIMS

- a. Claim(s) Missing
- b. Improper Dependency
- c. Duplicate Numbers
- d. Incorrect Numbering
- e. Index Disagrees
- f. Punctuation
- g. Amendments
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MESSAGE

PTD 1449- Please either initial or line through citations. Copy provided for reference.

Thank You
initials BSH

RESPONSE

initials

FORM PTO-1449 U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICE

ATTY. DOCKET NO.
2000P18622 US

SERIAL NO.

**INFORMATION DISCLOSURE
STATEMENT BY APPLICANT**

(Use several sheets if necessary)

(37 CFR 1.98(b))

APPLICANT
Guenter HAHN

FILING DATE
September 24, 2001

GROUP

0971 U.S. PTO
09/24/01
09/24/01

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		PATENT NUMBER	ISSUE DATE	PATENTEE	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA	5,353,238	10-94	NEEF et al.			
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						

FOREIGN PATENT OR PUBLISHED FOREIGN PATENT APPLICATION

		DOCUMENT NO.	PUBL. DATE	COUNTRY OR PATENT OFFICE	CLASS	SUB CLASS	TRANSLATION YES NO
	AJ	36 09 927 A1	10-87	GERMANY			NO
	AK	WO 87/06045	10-87	WIPO			NO
	AL	42 34 654 A1	04-94	GERMANY			NO
	AM	WO 98/25396	06-98	WIPO			NO
	AN	196 50 569 A1	06-98	GERMANY			NO

OTHER DOCUMENTS (Including Author, Title, Date, Relevant Pages, Place of Publication)

	AO	
	AP	
	AQ	

EXAMINER

DATE CONSIDERED

EXAMINER: Initial citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.